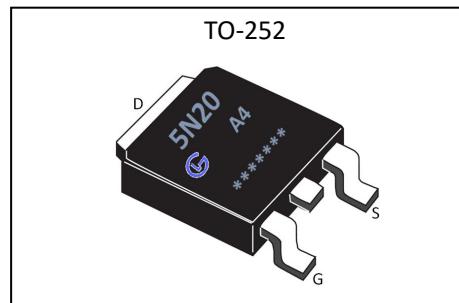


### General Description

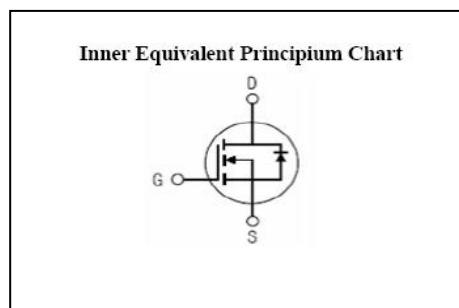
GL5N20A4 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-252, which accords with the RoHS standard.

$V_{DSS}$	200	V
$I_D$	5	A
$P_D$ ( $T_C=25^\circ\text{C}$ )	40	W
$R_{DS(\text{ON})\text{typ}}$	0.5	$\Omega$



### Features

- Fast Switching
- Low Gate Charge and  $R_{DS(on)}$
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test



### Applications

- LED Lighting
- Charger
- Standby Power

### Absolute ( $T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	200	V
$I_D$	Continuous Drain Current	5	A
	Continuous Drain Current $T_c = 100^\circ\text{C}$	3.5	A
$I_{DM}^{a1}$	Pulsed Drain Current	20	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}^{a2}$	Single Pulse Avalanche Energy	150	mJ
$dv/dt^{a3}$	Peak Diode Recovery $dv/dt$	5.0	V/ns
$P_D$	Power Dissipation	40	W
	Derating Factor above $25^\circ\text{C}$	0.6	$\text{W}/^\circ\text{C}$
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ\text{C}$
$T_L$	Maximum Temperature for Soldering	300	$^\circ\text{C}$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device



# GL5N20A4

## GL Silicon N-Channel Power MOSFET

**Electrical Characteristics** ( $T_c=25^\circ\text{C}$  unless otherwise specified)

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	200	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu\text{A}, \text{Reference } 25^\circ\text{C}$	--	0.21	--	$\text{V}/^\circ\text{C}$
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=200\text{V}, V_{GS}=0\text{V}, T_a=25^\circ\text{C}$	--	--	1	$\mu\text{A}$
		$V_{DS}=160\text{V}, V_{GS}=0\text{V}, T_a=125^\circ\text{C}$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30\text{V}$	--	--	100	$\mu\text{A}$
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30\text{V}$	--	--	-100	$\mu\text{A}$

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=2.5\text{A}$	--	0.5	0.65	$\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.7		2.0	V
Pulse width $tp \leq 300\mu\text{s}, \delta \leq 2\%$						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$g_{fs}$	Forward Transconductance	$V_{DS}=25\text{V}, I_D=2.5\text{A}$	--	2.0	--	S
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}$	--	230	--	$\text{pF}$
$C_{oss}$	Output Capacitance	$f=1.0\text{MHz}$	--	48	--	
$C_{rss}$	Reverse Transfer Capacitance		--	8	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=5\text{A}, V_{DD}=100\text{V}$	--	6	--	ns
$t_r$	Rise Time		--	12	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	24	--	
$t_f$	Fall Time		--	11	--	
$Q_g$	Total Gate Charge	$I_D=5\text{A}, V_{DD}=100\text{V}$	--	6.5	--	nC
$Q_{gs}$	Gate to Source Charge		--	2	--	
$Q_{gd}$	Gate to Drain ( "Miller" )Charge		--	3	--	



# GL5N20A4

*GL Silicon N-Channel Power MOSFET*

## Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	5	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	40	A
$V_{SD}$	Diode Forward Voltage	$I_S=5.0\text{A}, V_{GS}=0\text{V}$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S=5.0\text{A}, T_j=25^\circ\text{C}$	--	103	--	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=100\text{A/us},$	--	370	--	uC
$I_{RRM}$	Reverse Recovery Current	$V_{GS}=0\text{V}$	--	7.0	--	A

Pulse width  $t_p \leq 300\mu\text{s}, \delta \leq 2\%$

## Thermal Characteristics

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	3.13	°C/W
$R_{\theta JA}$	Junction-to-Ambient	62.5	°C/W

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>:  $L=10.0\text{mH}, I_D=5.5\text{A}, \text{Start } T_j=25^\circ\text{C}$

<sup>a3</sup>:  $I_{SD} = 5\text{A}, di/dt \leq 100\text{A/us}, V_{DD} \leq BV_{DS}, \text{Start } T_j=25^\circ\text{C}$

## Characteristics Curves

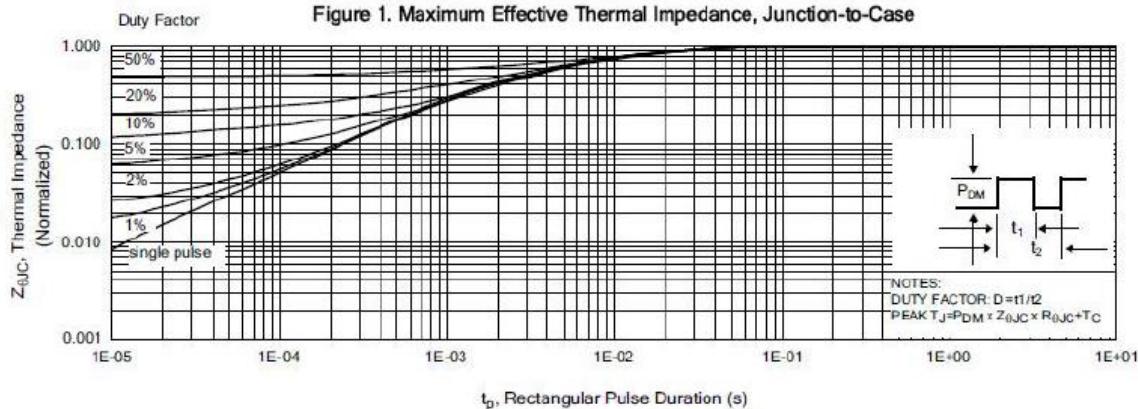


Figure 2. Maximum Power Dissipation vs Case Temperature

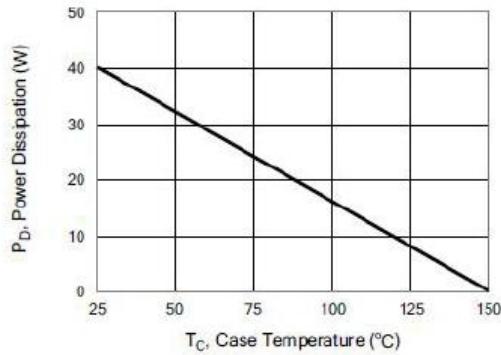


Figure 4. Typical Output Characteristics

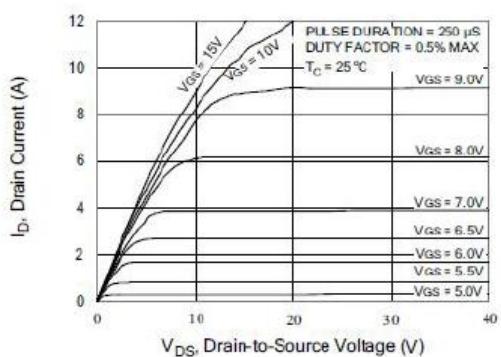


Figure 3. Maximum Continuous Drain Current vs Case Temperature

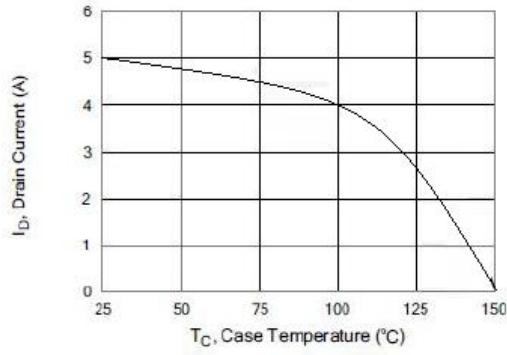
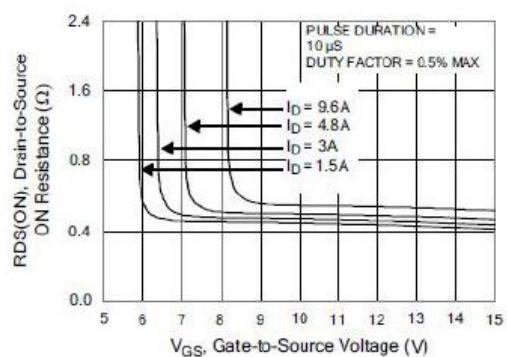
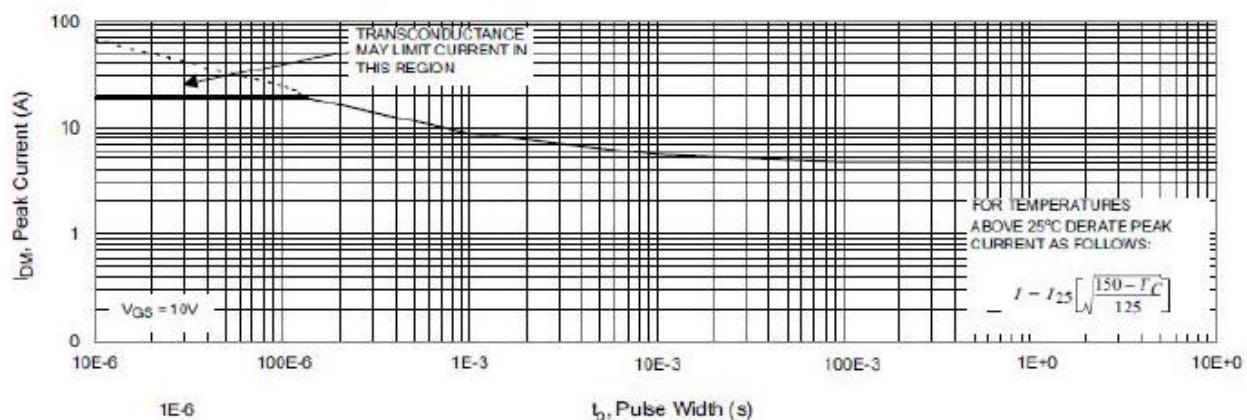
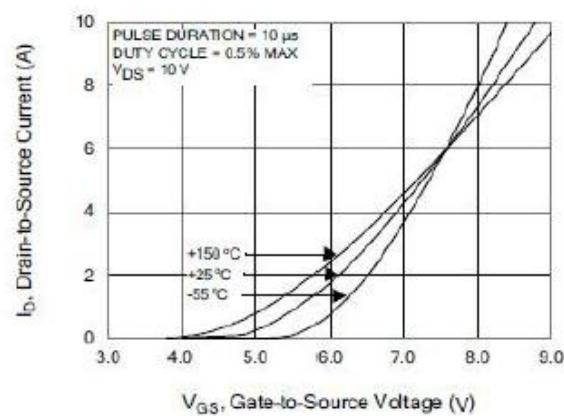
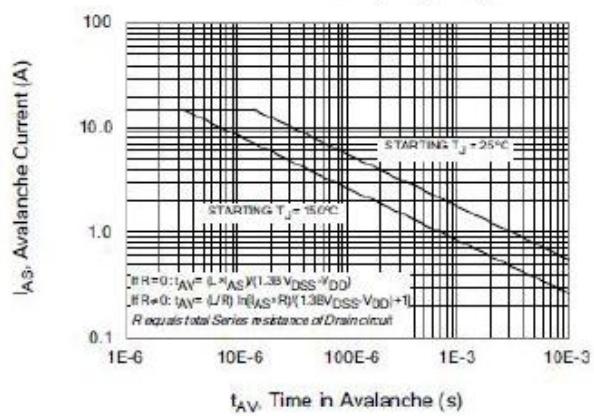
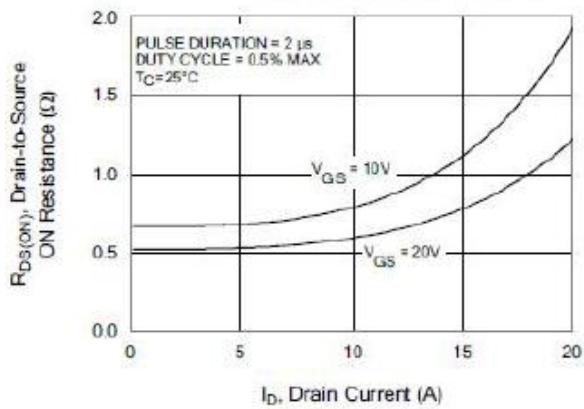
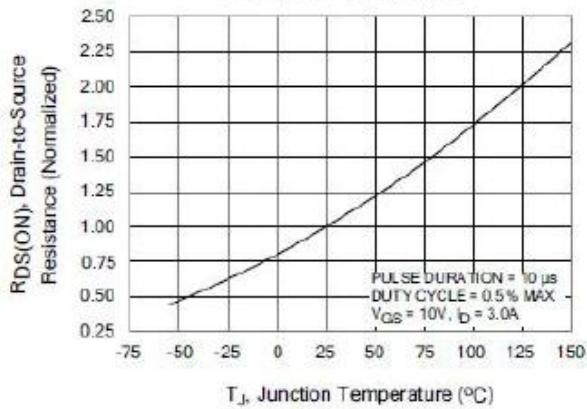
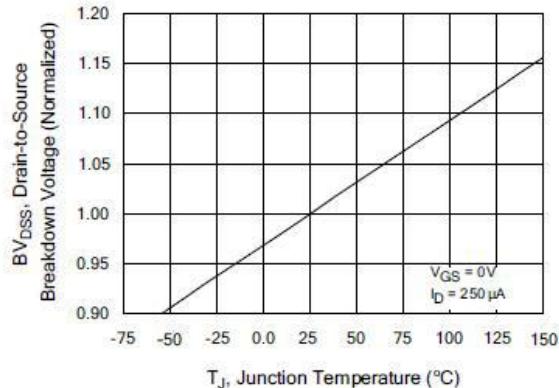


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current

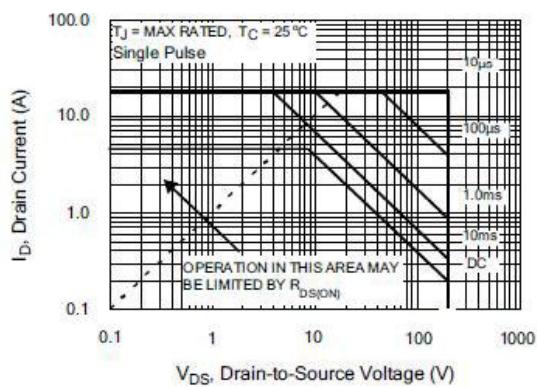


**Figure 6. Maximum Peak Current Capability**

**Figure 7. Typical Transfer Characteristics**

**Figure 8. Unclamped Inductive Switching Capability**

**Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current**

**Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature**


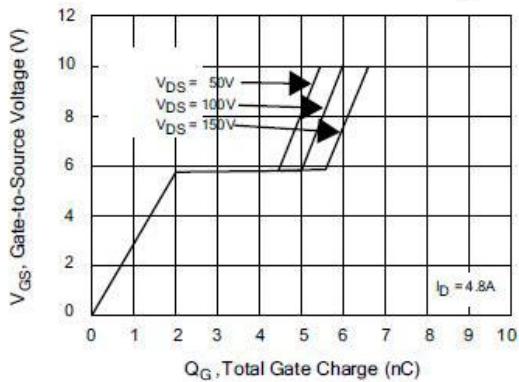
**Figure 11. Typical Breakdown Voltage vs Junction Temperature**



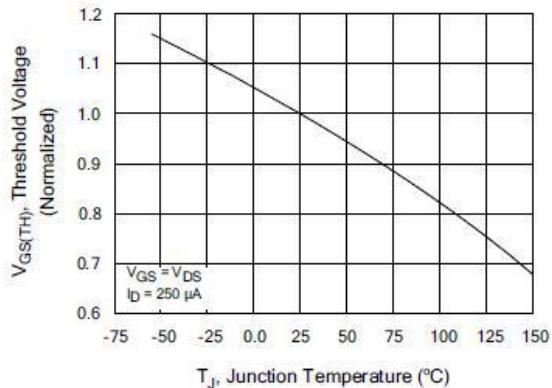
**Figure 13. Maximum Forward Bias Safe Operating Area**



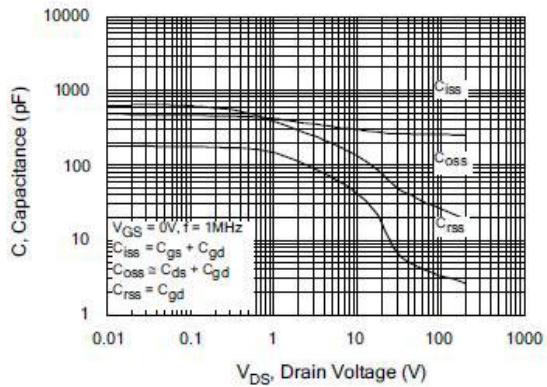
**Figure 15. Typical Gate Charge vs Gate-to-Source Voltage**



**Figure 12. Typical Threshold Voltage vs Junction Temperature**



**Figure 14. Typical Capacitance vs Drain-to-Source Voltage**



**Figure 16. Typical Body Diode Transfer Characteristics**

